

DIODES

SCA1N5802 * SCA1N5804 * SCA1N5806

RECTIFIERS

High Power / Ultra Fast Recovery / Radiation Hardness Assured

DESCRIPTION

This "high reliability ultra fast recovery" rectifier diode family is superior in leakage current and suitable for numerous applications in space and military area. Constructed in glass packages using an internal category-Imetallurgical bond tested per MIL-PRF-19500, these rectifiers offer the working peak reverse voltage from 50 to 150V with 2.5A maximum current rating and ultra fast switching characteristics. These devices are also available in SMT packages and bare dies to meet the most stringent applications.

FEATURES

- Superior construction with tungsten slugs
- Category-I metallurgical bonds
- Hermetical sealed glass package
- Low forward voltage drop

- Highly stable reverse breakdown characteristics
- Fast switching with no snap-off
- High forward surge capability
- Also provided in various surface mount type packages and bare die
- Radiation hard version is available

APPLICATIONS

- Space, military and other high-reliability applications
- Ultra fast switching power supplies requiring low forward voltage drop.

PACKAGING

- Axial lead
- SMT (Other)
- SMT (US)
- Bare die for HYBRID manufacturers

ELECTRICAL CHARACTERISTICS	Operating Conditions	min	typ	max	unit	symbol
Reverse current	Rated VRWM, TA=+25°C	-	TBD	1	uA	IR1
	Rated VRWM, TA=+125°C	-	TBD	175	uA	IR2
Forward voltage drop	IF=1A, TA=+25°C	-	TBD	0.875	V	VF3
	IF=2.5A, TA=+25°C	-	TBD	0.975	V	VF4
	IF=1A, TA=+125°C	-	TBD	0.800	V	VF7
	IF=1A, TA=-65°C	-	TBD	1.075	V	VF9
Breakdown voltage						
SCA1N5802	IBR=100uA, Ta=+25°C	60	TBD	-	V	VBR1
SCA1N5804	IBR=100uA, Ta=+25°C	110	TBD	-	V	
SCA1N5806	IBR=100uA, Ta=+25°C	160	TBD	-	V	
SCA1N5802 IBR=100uA, TA=-65°C		50	TBD	-	V	VBR2
SCA1N5804	IBR=100uA, Ta=-65°C	100	TBD	-	V	
SCA1N5806	IBR=100uA, Ta=-65°C	150	TBD	-		
Junction capacitance	VBR=10V, f=1MHz	-	TBD	25	pF	Cj
SWITCHING CHARACTERISTICS						
Reverse recovery time	IF=IRM=0.5A, IREC=0.5A		TBD	25	nsec	Trr
Forward recovery voltage	Tr=8ns, IF=250mA		TBD	2.2	V	V(peak)
Forward recovery time	Tr=8ns, IF=250mA		TBD	15	nsec	Tfr

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MAX RATINGS	reverse voltage	forward		_	Reverse recovery time		Thermal resistance: junction to end-cap	Thermal reistance (θ)
	V RWM	lo(L)	l 01	IFSM	trr	Rejl	Rөлес	Rелх
		TL=+75°C						
		L = 0.375	Ta=+55°C	Ta = +25°C				
		in.		operating at Io1				
		(1) (2).	(3) (4).	tp = 8.3ms		at L=0.375 in.	(5).	(3).
	V	Α	Α	A(pk)	ns	°C/W	°C/W	°C/W
SCA1N5802	50.0	2.5	1.0	35.0	25.0	36.0	13.0	154.0
SCA1N5804	100.0	2.5	1.0	35.0	25.0	36.0	13.0	154.0
SCA1N5806	150.0	2.5	1.0	35.0	25.0	36.0	13.0	154.0

(1). TEC = TL at L = 0 or Tend tab for US devices

Derate at 25mA/°C for TL above +75°C for 2.5A ratings. (2).

(3). For the 1.0A ratings at 55°C, these IO ratings are for thermally (PC boards or other) mounting methods

where the thermal resistance from mounting point to ambient is still sufficiently controlled where TI(MAX) does

(4). Derate at 8.33mA/°C for TA above +55°C for 1.0A ratings.

US device only (5).

DKG TVDF

1N58<mark>06 Packaging</mark> **PACKAGING SPECIFICATIONS** Axial Lead PKG TYPE

PROTTPE	Axidi Ledu					
	Min	Тур	Max	-		
BD	0.065	TBD	0.850	inches		
BL	0.125	TBD	0.250	inches		
LD	0.027	TBD <	0.032	inches		
LL	0.700	TBD	1.300	inches		

PKG TYPE	US			
	Min	Тур	Max	
BD	0.091	TBD	0.103	inches
BL	0.168	TBD	0.200	inches
ECT	0.019	TBD	0.028	inches
S	0.003	TBD		inches

FROTIFL	IVILLI	(וטטו)		
	Min	Тур	Max	
TBD	TBD	TBD	TBD	inches
TBD	TBD	TBD	TBD	inches
TBD	TBD	TBD	TBD	inches
TBD	TBD	TBD	TBD	inches

MELE (TRD)

PKG TYPE	Die Square				
	Min	Тур	Max		Note
Α	0.068	TBD	0.072	inches	
В	0.057	TBD	0.061	inches	
С	0.008	TBD	0.012	inches	
Top Metal	38.000	TBD	-	kA	Anode - Al
Back Metal	3.500	TBD	-	kA	Cathode - Au









